

<b>Notice of References Cited</b>	Application/Control No. 10/759,169	Applicant(s)/Patent Under Reexamination KAWAZU ET AL.	
	Examiner Sophia S. Chen	Art Unit 2852	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,444,521	08-1995	Tomoyuki et al.	399/69
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N	JP 06-131061 A	05-1994	Japan	Matsudaira et al.	-----/-----
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	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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